Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/775,418	HARVIE, MARK R.
Examiner	Art Unit
Chen-Wen Jiang	3744

SEARCHED					
Class	Subclass	Date	Examiner		
62	3.5				
	3.3				
	259.3				
607	261				
	289	12/6/2005	Cl		
			i		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Searched EAST Searched	12/6/2005	Cl		
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